

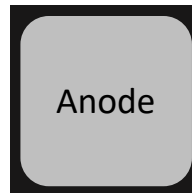
| | |
|-------------|--------|
| V_{DC} | 1700 V |
| Q_C | 52 nC |
| I_F | 5 A |
| $T_{j,max}$ | 175 °C |

1700V/5A SiC Schottky Diode Bare Die

Amp+™ Features

- Unipolar rectifier with surge current
- Zero reverse recovery current
- Fast, temperature-independent switching
- Reduced temperature dependence of V_F

Chip Outline



| Part # | Die Size | Anode | Cathode |
|--------------|----------------|-------|---------|
| GP3D005A170X | 2.16 x 2.16 mm | Al | Ni/Ag |

Maximum Ratings, at $T_j=25$ °C, unless otherwise specified

| Characteristics | Symbol | Conditions | Values | Unit |
|--|--------------------|-------------------------------|-----------|------|
| Continuous forward current | I_F | $T_C=25$ °C, $T_j=175$ °C | 21* | A |
| | | $T_C=125$ °C, $T_j=175$ °C | 11* | |
| | | $T_C=150$ °C, $T_j=175$ °C | 7* | |
| Surge non-repetitive forward current sine halfwave | I_{FSM} | $T_C=25$ °C, $t_p=8.3$ ms | 75* | A |
| | | $T_C=110$ °C, $t_p=8.3$ ms | 60* | |
| Non-repetitive peak forward current | $I_{F,max}$ | $T_C=25$ °C, $t_p=10$ μ s | 440 | A |
| Repetitive peak reverse voltage | V_{RRM} | $T_j=25$ °C | 1700** | V |
| Operating junction & storage temperature | $T_j, T_{storage}$ | Continuous | -55...175 | °C |

Values have been verified on TO-247 packaged devices

*Assumes R_{thJC} thermal resistance of 1.07°C/W with recommended wire bond

** Verified by 100% wafer test

Electrical Characteristics, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

| Characteristics | Symbol | Conditions | Values | | | Unit |
|-------------------------|----------|---|--------|------|------|---------------|
| | | | min. | typ. | max. | |
| DC blocking voltage | V_{DC} | $T_j=25\text{ }^\circ\text{C}$ | 1700** | - | - | V |
| Diode forward voltage | V_F | $I_F=5\text{A}, T_j=25\text{ }^\circ\text{C}$ | - | 1.50 | 1.65 | V |
| | | $I_F=5\text{A}, T_j=125\text{ }^\circ\text{C}$ | - | 1.96 | - | |
| | | $I_F=5\text{A}, T_j=175\text{ }^\circ\text{C}$ | - | 2.33 | 2.55 | |
| Reverse current | I_R | $V_R=1700\text{V}, T_j=25\text{ }^\circ\text{C}$ | - | 1** | 20** | μA |
| | | $V_R=1700\text{V}, T_j=125\text{ }^\circ\text{C}$ | - | 6 | - | |
| | | $V_R=1700\text{V}, T_j=175\text{ }^\circ\text{C}$ | - | 23 | 200 | |
| Total capacitive charge | Q_C | $V_R=1700\text{V}, T_j=25\text{ }^\circ\text{C}$ | - | 52 | - | nC |
| Total capacitance | C | $V_R=1\text{V}, f=1\text{ MHz}$ | - | 347 | - | pF |
| | | $V_R=800\text{V}, f=1\text{ MHz}$ | - | 23 | - | |
| | | $V_R=1700\text{V}, f=1\text{ MHz}$ | - | 22 | - | |

Values have been verified on TO-247 packaged devices

*Assumes R_{thJC} thermal resistance of $1.07\text{ }^\circ\text{C/W}$ with recommended wire bond

** Verified by 100% wafer test

Mechanical Parameters

| Parameter | Typ. | Unit |
|--------------------------------|------------------------------|---------------|
| Die Size | 2.16 x 2.16 | mm |
| Anode Pad Opening | 0.84 x 0.84 | mm |
| Recommended Wire Bond (TO-247) | 15 mil x 1 | mil |
| Die Thickness | 360 ± 25 | μm |
| Wafer Size | 150 | mm |
| Anode Metalization (Al) | 4 | μm |
| Cathode Metalization (Ni/Ag) | | μm |
| Frontside Passivation | Polyimide on Silicon Nitride | |

Typical Performance in packaged device

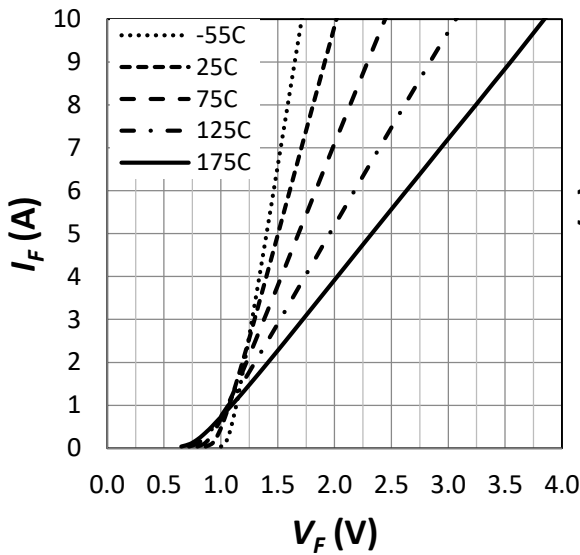


Fig. 1 Forward Characteristics

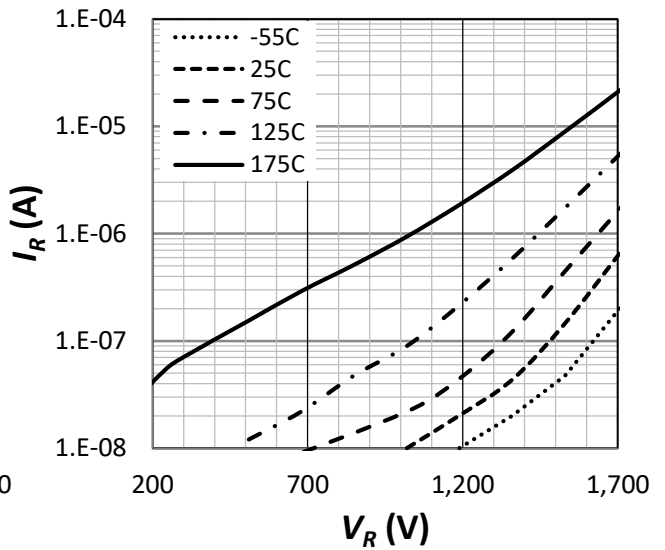


Fig. 2 Reverse Characteristics

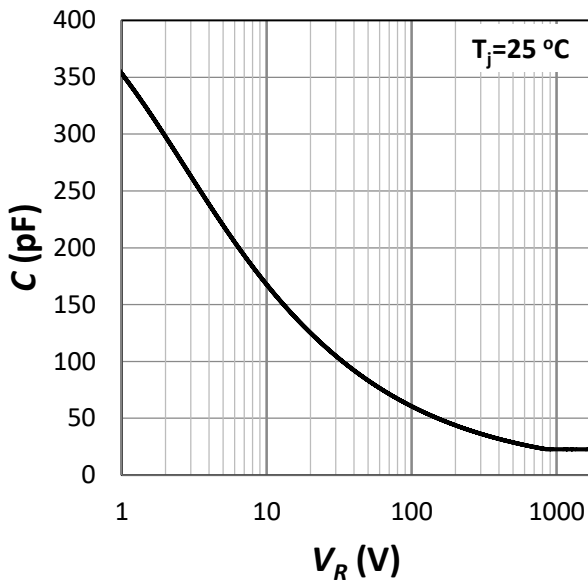


Fig. 3 Capacitance vs. Reverse Voltage

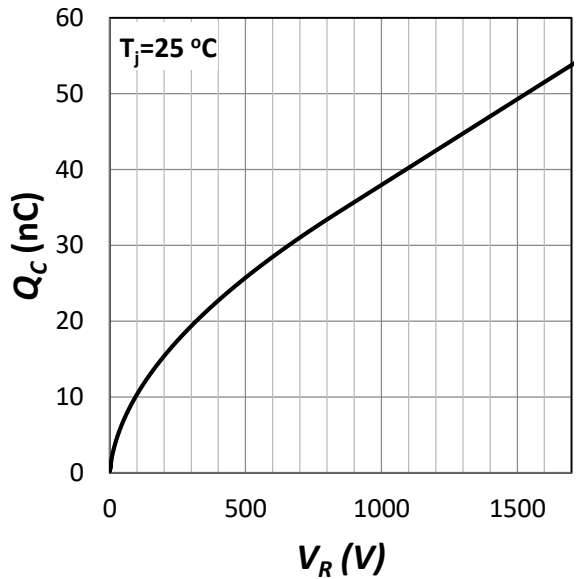


Fig. 4 Capacitive Charge vs. Reverse Voltage

Notes**RoHS Compliance**

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